

L Number	Hits	Search Text	DB	Time stamp
1	159726	surface near5 (inspect\$4 or detect\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 12:28
2	653055	upper near3 surface	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 12:29
3	369694	bottom near4 surface	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 12:29
4	265033	front near4 surface	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 12:30
5	198234	rear near4 surface	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 12:30
6	124354	(upper near3 surface ) and (bottom near4 surface)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 12:30
7	82941	(front near4 surface) and (rear near4 surface)	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 12:30
8	197806	((upper near3 surface ) and (bottom near4 surface)) or ((front near4 surface) and (rear near4 surface))	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 12:30
9	6880	(surface near5 (inspect\$4 or detect\$4)) and (((upper near3 surface ) and (bottom near4 surface)) or ((front near4 surface) and (rear near4 surface)))	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 12:31
10	711	defects and ((surface near5 (inspect\$4 or detect\$4)) and (((upper near3 surface ) and (bottom near4 surface)) or ((front near4 surface) and (rear near4 surface))))	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 12:57
11	11	4541715.URPN.	USPAT	2004/07/28 12:47
12	4	("4330205"   "4389084"   "4443096"   "4468120").PN.	USPAT	2004/07/28 12:48
13	329234	wafer	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 13:19
14	213	(defects and ((surface near5 (inspect\$4 or detect\$4)) and (((upper near3 surface ) and (bottom near4 surface)) or ((front near4 surface) and (rear near4 surface)))) and wafer	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/28 13:19